

BFU690F

NPN wideband silicon RF transistor

Rev. 2 — 14 March 2014

Product data sheet

1. Product profile

1.1 General description

NPN silicon microwave transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

1.2 Features and benefits

- Low noise high linearity microwave transistor
- High output third-order intercept point 34 dBm at 1.8 GHz
- 40 GHz f_T silicon technology

1.3 Applications

- Ka band oscillators DRO's
- C-band high output buffer amplifier
- ZigBee
- LTE, cellular, UMTS

1.4 Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--------------|---------------------------------------|--|-----|------|-----|------|
| V_{CBO} | collector-base voltage | open emitter | - | - | 16 | V |
| V_{CEO} | collector-emitter voltage | open base | - | - | 5.5 | V |
| V_{EBO} | emitter-base voltage | open collector | - | - | 2.5 | V |
| I_C | collector current | | - | 70 | 100 | mA |
| P_{tot} | total power dissipation | $T_{sp} \leq 85\text{ °C}$ [1] | - | - | 490 | mW |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}$; $V_{CE} = 2\text{ V}$; $T_j = 25\text{ °C}$ | 90 | 135 | 180 | |
| C_{CBS} | collector-base capacitance | $V_{CB} = 2\text{ V}$; $f = 1\text{ MHz}$ | - | 404 | - | fF |
| f_T | transition frequency | $I_C = 60\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | - | 18 | - | GHz |
| $G_{p(max)}$ | maximum power gain | $I_C = 60\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1.8\text{ GHz}$; $T_{amb} = 25\text{ °C}$ [2] | - | 20.5 | - | dB |
| NF | noise figure | $I_C = 15\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 1.8\text{ GHz}$; $\Gamma_S = \Gamma_{opt}$ | - | 0.65 | - | dB |
| $P_{L(1dB)}$ | output power at 1 dB gain compression | $I_C = 70\text{ mA}$; $V_{CE} = 4\text{ V}$; $Z_S = Z_L = 50\text{ }\Omega$; $f = 1.8\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | - | 22 | - | dBm |

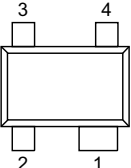
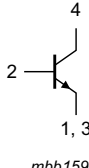
[1] T_{sp} is the temperature at the solder point of the emitter lead.

[2] $G_{p(max)}$ is the maximum power gain, if $K > 1$. If $K < 1$ then $G_{p(max)} = \text{Maximum Stable Gain (MSG)}$.



2. Pinning information

Table 2. Discrete pinning

| Pin | Description | Simplified outline | Graphic symbol |
|-----|-------------|---|---|
| 1 | emitter |  |  |
| 2 | base | | |
| 3 | emitter | | |
| 4 | collector | | |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|-------------|---------|---|---------|
| | Name | Description | Version |
| BFU690F | - | plastic surface-mounted flat pack package; reverse pinning; 4 leads | SOT343F |

4. Marking

Table 4. Marking

| Type number | Marking | Description |
|-------------|---------|---------------------------|
| BFU690F | D4* | * = p : made in Hong Kong |
| | | * = t : made in Malaysia |
| | | * = w : made in China |

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------|---------------------------|--------------------------------|-----|------|------|
| V_{CBO} | collector-base voltage | open emitter | - | 16 | V |
| V_{CEO} | collector-emitter voltage | open base | - | 5.5 | V |
| V_{EBO} | emitter-base voltage | open collector | - | 2.5 | V |
| I_C | collector current | | - | 100 | mA |
| P_{tot} | total power dissipation | $T_{sp} \leq 85\text{ °C}$ [1] | - | 490 | mW |
| T_{stg} | storage temperature | | -65 | +150 | °C |
| T_j | junction temperature | | - | 150 | °C |

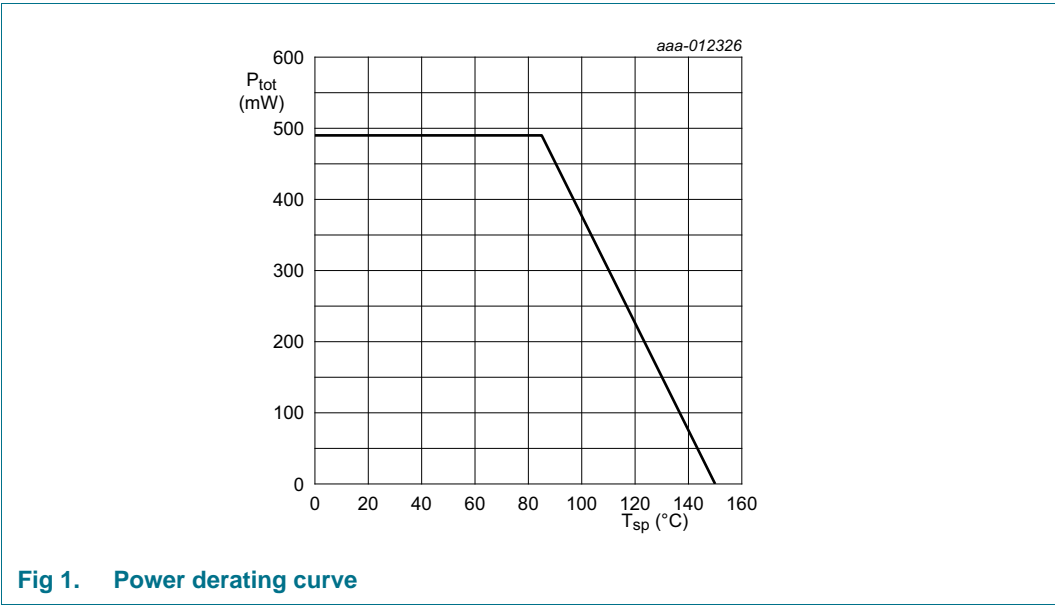
[1] T_{sp} is the temperature at the solder point of the emitter lead.

6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Typ | Unit |
|----------------|--|------------|---------|------|
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point | | [1] 132 | K/W |

[1] Determined by simulation.

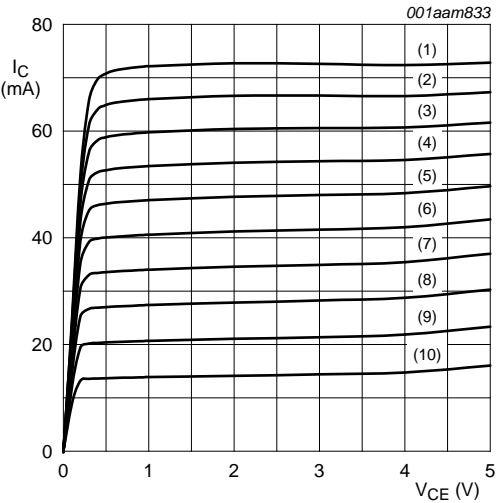


7. Characteristics

Table 7. Characteristics
 $T_j = 25\text{ °C}$ unless otherwise specified

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---------------|---------------------------------------|--|-----|------|-----|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\text{ }\mu\text{A}$; $I_E = 0\text{ mA}$ | 16 | - | - | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 1\text{ mA}$; $I_B = 0\text{ mA}$ | 5.5 | - | - | V |
| I_C | collector current | | - | 70 | 100 | mA |
| I_{CBO} | collector-base cut-off current | $I_E = 0\text{ mA}$; $V_{CB} = 8\text{ V}$ | - | - | 100 | nA |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}$; $V_{CE} = 2\text{ V}$ | 90 | 135 | 180 | |
| C_{CES} | collector-emitter capacitance | $V_{CB} = 2\text{ V}$; $f = 1\text{ MHz}$ | - | 527 | - | fF |
| C_{EBS} | emitter-base capacitance | $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | - | 1699 | - | fF |
| C_{CBS} | collector-base capacitance | $V_{CB} = 2\text{ V}$; $f = 1\text{ MHz}$ | - | 404 | - | fF |
| f_T | transition frequency | $I_C = 60\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | - | 18 | - | GHz |
| $G_{p(max)}$ | maximum power gain | $I_C = 60\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ °C}$ [1] | | | | |
| | | $f = 1.5\text{ GHz}$ | - | 22 | - | dB |
| | | $f = 1.8\text{ GHz}$ | - | 20.5 | - | dB |
| | | $f = 2.4\text{ GHz}$ | - | 17 | - | dB |
| $ s_{21} ^2$ | insertion power gain | $I_C = 60\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ °C}$ | | | | |
| | | $f = 1.5\text{ GHz}$ | - | 15 | - | dB |
| | | $f = 1.8\text{ GHz}$ | - | 13.5 | - | dB |
| | | $f = 2.4\text{ GHz}$ | - | 11 | - | dB |
| NF | noise figure | $I_C = 15\text{ mA}$; $V_{CE} = 2\text{ V}$; $\Gamma_S = \Gamma_{opt}$; $T_{amb} = 25\text{ °C}$ | | | | |
| | | $f = 1.5\text{ GHz}$ | - | 0.60 | - | dB |
| | | $f = 1.8\text{ GHz}$ | - | 0.65 | - | dB |
| | | $f = 2.4\text{ GHz}$ | - | 0.70 | - | dB |
| G_{ass} | associated gain | $I_C = 15\text{ mA}$; $V_{CE} = 2\text{ V}$; $\Gamma_S = \Gamma_{opt}$; $T_{amb} = 25\text{ °C}$ | | | | |
| | | $f = 1.5\text{ GHz}$ | - | 18.5 | - | dB |
| | | $f = 1.8\text{ GHz}$ | - | 17.5 | - | dB |
| | | $f = 2.4\text{ GHz}$ | - | 15.5 | - | dB |
| $P_{L(1dB)}$ | output power at 1 dB gain compression | $I_C = 70\text{ mA}$; $V_{CE} = 4\text{ V}$; $Z_S = Z_L = 50\text{ }\Omega$; $T_{amb} = 25\text{ °C}$ | | | | |
| | | $f = 1.5\text{ GHz}$ | - | 22 | - | dBm |
| | | $f = 1.8\text{ GHz}$ | - | 22 | - | dBm |
| | | $f = 2.4\text{ GHz}$ | - | 20 | - | dBm |
| IP3 | third-order intercept point | $I_C = 70\text{ mA}$; $V_{CE} = 4\text{ V}$; $Z_S = Z_L = 50\text{ }\Omega$; $T_{amb} = 25\text{ °C}$ | | | | |
| | | $f = 1.5\text{ GHz}$ | - | 34 | - | dBm |
| | | $f = 1.8\text{ GHz}$ | - | 34 | - | dBm |
| | | $f = 2.4\text{ GHz}$ | - | 33 | - | dBm |

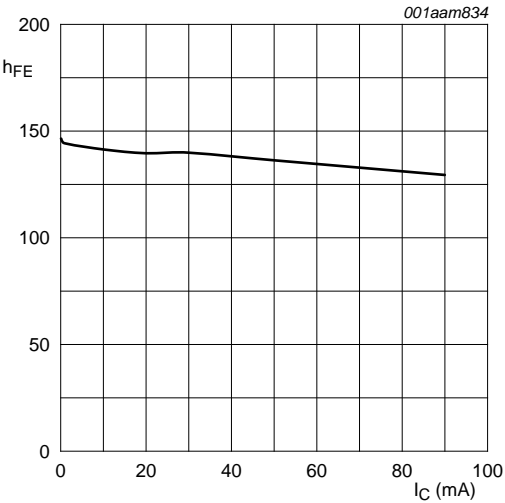
[1] $G_{p(max)}$ is the maximum power gain, if $K > 1$. If $K < 1$ then $G_{p(max)} = MSG$.



$T_{amb} = 25\text{ }^{\circ}\text{C}.$

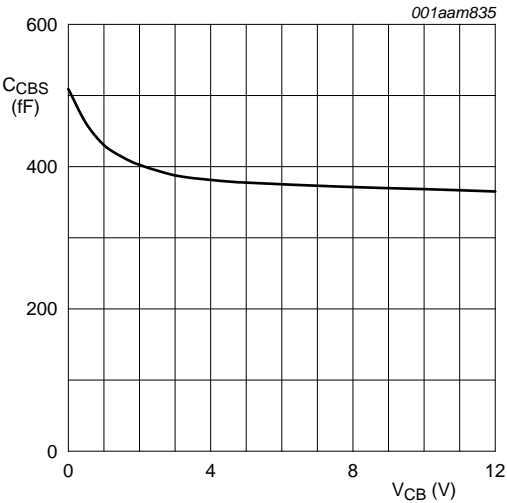
- (1) $I_B = 550\text{ }\mu\text{A}$
- (2) $I_B = 500\text{ }\mu\text{A}$
- (3) $I_B = 450\text{ }\mu\text{A}$
- (4) $I_B = 400\text{ }\mu\text{A}$
- (5) $I_B = 350\text{ }\mu\text{A}$
- (6) $I_B = 300\text{ }\mu\text{A}$
- (7) $I_B = 250\text{ }\mu\text{A}$
- (8) $I_B = 200\text{ }\mu\text{A}$
- (9) $I_B = 150\text{ }\mu\text{A}$
- (10) $I_B = 100\text{ }\mu\text{A}$

Fig 2. Collector current as a function of collector-emitter voltage; typical values



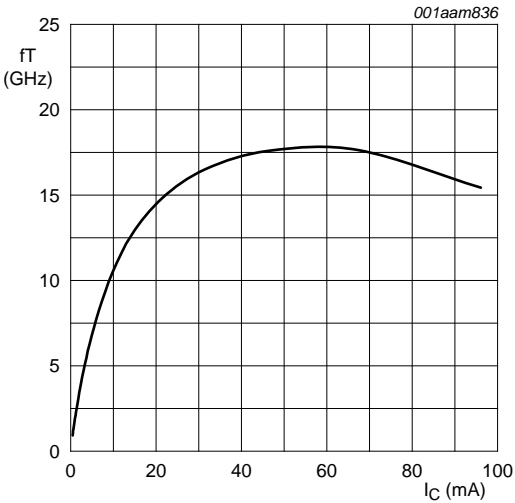
$V_{CE} = 2\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}.$

Fig 3. DC current gain as a function of collector current; typical values



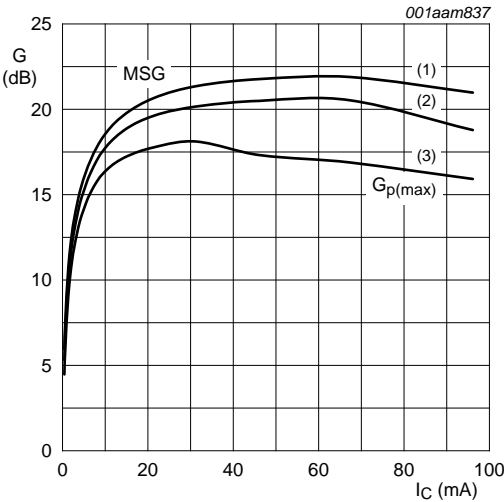
$f = 1\text{ MHz}$, $T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values



$V_{CE} = 1\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

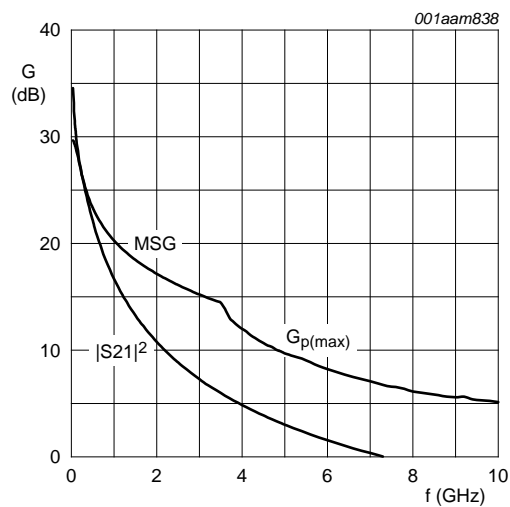
Fig 5. Transition frequency as a function of collector current; typical values



$V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$.

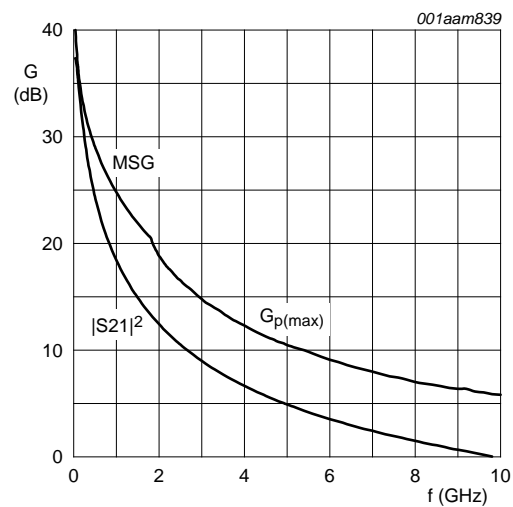
- (1) $f = 1.5\text{ GHz}$
- (2) $f = 1.8\text{ GHz}$
- (3) $f = 2.4\text{ GHz}$

Fig 6. Gain as a function of collector current; typical value



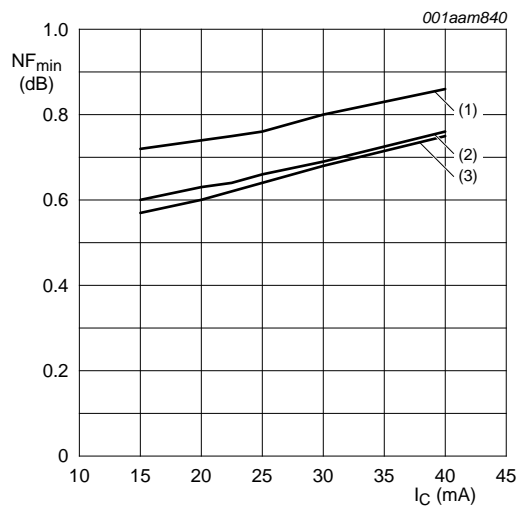
$V_{CE} = 1\text{ V}$; $I_C = 10\text{ mA}$; $T_{amb} = 25\text{ °C}$.

Fig 7. Gain as a function of frequency; typical values



$V_{CE} = 1\text{ V}$; $I_C = 60\text{ mA}$; $T_{amb} = 25\text{ °C}$.

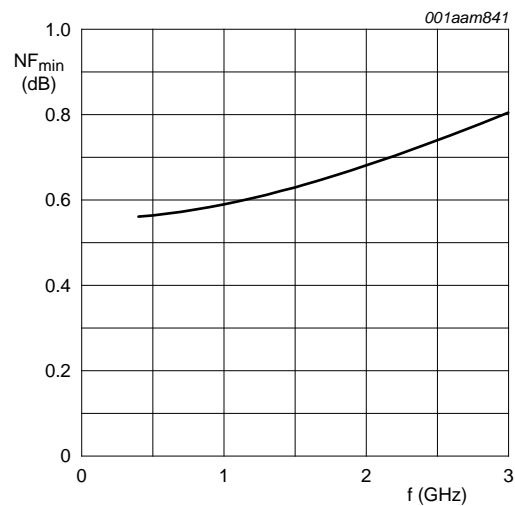
Fig 8. Gain as a function of frequency; typical values



$V_{CE} = 2\text{ V}$; $T_{amb} = 25\text{ °C}$.

- (1) $f = 2.4\text{ GHz}$
- (2) $f = 1.8\text{ GHz}$
- (3) $f = 1.5\text{ GHz}$

Fig 9. Minimum noise figure as a function of collector current; typical values



$V_{CE} = 2\text{ V}$; $I_C = 15\text{ mA}$; $T_{amb} = 25\text{ °C}$.

Fig 10. Minimum noise figure as a function of frequency; typical values

8. Package outline

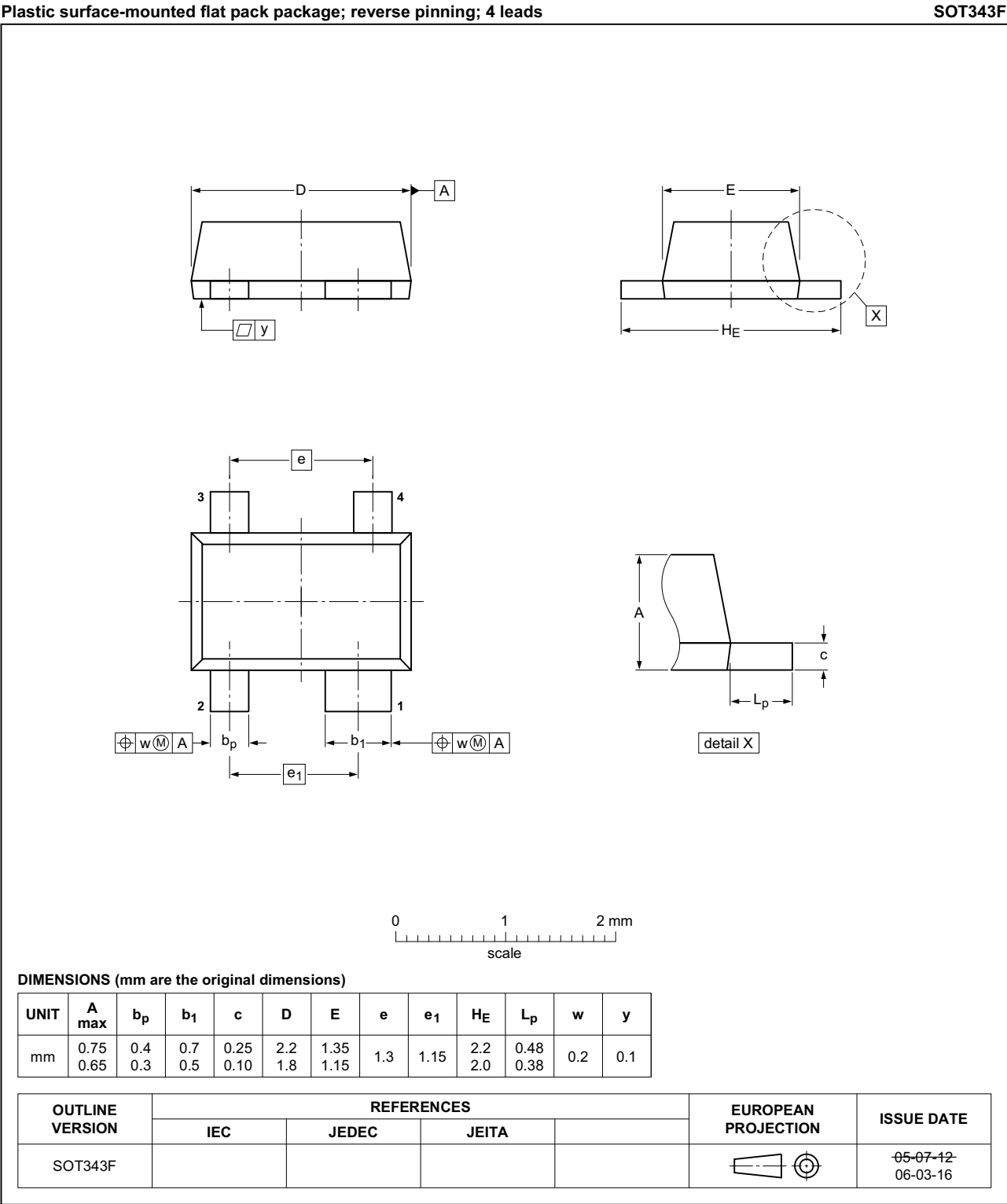


Fig 11. Package outline SOT343F

9. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

10. Abbreviations

Table 8. Abbreviations

| Acronym | Description |
|---------|--|
| DRO | Dielectric Resonator Oscillator |
| Ka | Kurtz above |
| LTE | Long Term Evolution |
| NPN | Negative-Positive-Negative |
| UMTS | Universal Mobile Telecommunications System |

11. Revision history

Table 9. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------|---|--------------------|---------------|-------------|
| BFU690F v.2 | 20140314 | Product data sheet | - | BFU690F v.1 |
| Modifications: | <ul style="list-style-type: none"> Table 1 on page 1: The value and conditions for P_{tot} have been updated. Table 5 on page 2: The value and conditions for P_{tot} have been updated. Table 6 on page 3: The value and conditions for $R_{th(j-sp)}$ have been updated. Figure 1 on page 3: The graph has been updated. Section 9 on page 9: The ESD caution has been moved here from Section 1.1 on page 1. | | | |
| BFU690F v.1 | 20101216 | Product data sheet | - | - |

12. Legal information

12.1 Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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For sales office addresses, please send an email to: salesaddresses@nxp.com

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- Поставка образцов и прототипов;
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